

July 2008

FDZ1905PZ

Common Drain P-Channel 1.5V PowerTrench® WL-CSP MOSFET -20V, -3A, $123m\Omega$

Features

- Max $r_{S1S2(on)} = 126m\Omega$ at $V_{GS} = -4.5V$, $I_{S1S2} = -1A$
- Max $r_{S1S2(on)} = 141 m\Omega$ at $V_{GS} = -2.5 V$, $I_{S1S2} = -1 A$
- Max $r_{S1S2(on)} = 198m\Omega$ at $V_{GS} = -1.8V$, $I_{S1S2} = -1A$
- Max $r_{S1S2(on)} = 303m\Omega$ at $V_{GS} = -1.5V$, $I_{S1S2} = -1A$
- Occupies only 1.5 mm² of PCB area, less than 50% of the area of 2 x 2 BGA
- Ultra-thin package: less than 0.65 mm height when mounted to PCB
- High power and current handling capability
- HBM ESD protection level > 4kV (Note 3)
- RoHS Compliant

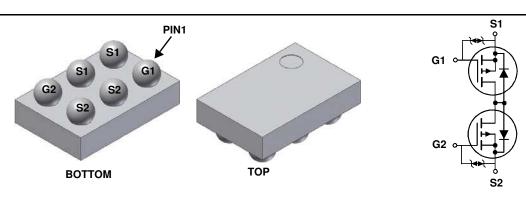


General Description

This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features two common drain P-channel MOSFETs, which enables bidirectional current flow, on Fairchild's advanced 1.5V PowerTrench® process with state of the art "low pitch" WL-CSP packaging process, the FDZ1905PZ minimizes both PCB space and $r_{S1S2(on)}$. This advanced WL-CSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge, and low $r_{S1S2(on)}$.

Applications

- Battery management
- Load switch
- Battery protection



MOSFET Maximum Ratings T_A = 25℃ unless otherwise noted

Symbol	Para		Ratings	Units	
V _{S1S2}	Source1 to Source2 Voltage			-20	V
V_{GS}	Gate to Source Voltage			±8	V
I _{S1S2}	Source1 to Source2 Current -Continu	uous T _A = 25℃	(Note 1a)	-3	۸
	-Pulsed			-15	A
P _D	Power Dissipation (Steady State)	T _A = 25℃	(Note 1a)	1.5	W
	Power Dissipation	T _A = 25℃	(Note 1b)	0.9	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	83	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	140	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	ckage Reel Size Tape Wi		Quantity	
5	FDZ1905PZ	WL-CSP 1.0X1.5	7"	8mm	5000 units	

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Characteristics						
I _{S1S2}	Zero Gate Voltage Source1 to Source2 Current	$V_{S1S2} = -16V, \ V_{GS} = 0V$			-1	μА
I _{GSS}	Gate Body Leakage Current	$V_{GS} = \pm 8V, V_{S1S2} = 0V$			±10	uA

On Characteristics (Note 2)

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{S1S2}, I_{S1S2} = -250 \mu A$	-0.4	-0.7	-1.0	V
r _{S1S2(on)} Sta		$V_{GS} = -4.5V, I_{S1S2} = -1A$		99	126	
		$V_{GS} = -2.5V, I_{S1S2} = -1A$		112	141	
	Static Source 1 to Source2 On Resistance	$V_{GS} = -1.8V, I_{S1S2} = -1A$		132	198	mΩ
		$V_{GS} = -1.5V, I_{S1S2} = -1A$		164	303	11122
		$V_{GS} = -4.5V$, $I_{S1S2} = -1A$, $T_J = 125$ °C		135	195	
9 _{FS}	Forward Transconductance	$V_{S1S2} = -5V, I_{S1S2} = -1A$		8		S

Switching Characteristics (Note 2)

$t_{d(on)}$	Turn-On Delay Time		12	22	ns
t _r	Rise Time	$V_{S1S2} = -10V, I_{S1S2} = -1A$	36	58	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -4.5V$, $R_{GEN} = 6\Omega$	143	229	ns
t _f	Fall Time		182	291	ns

Notes:1. $R_{\theta,JA}$ is determined with the device mounted on a $1in^2$ pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 83 °C/W when mounted on a 1 in² pad of 2 oz copper



b.140 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300ms, Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

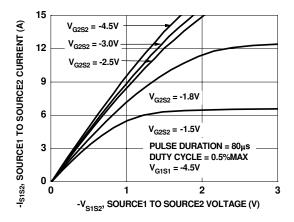


Figure 1. On Region Characteristics

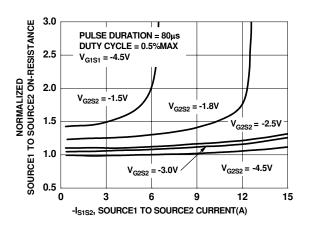


Figure 3. Normalized On-Resistance vs Drain Current and Gate Voltage

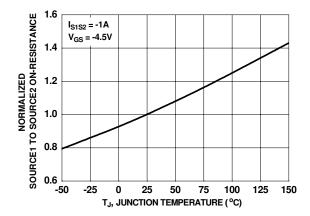


Figure 5. Normalized On Resistance vs Junction Temperature

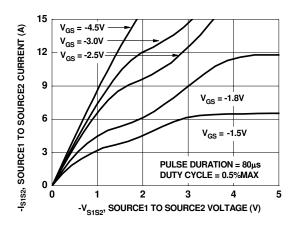


Figure 2. On Region Characteristics

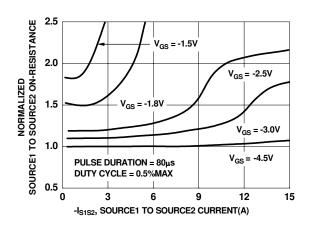


Figure 4. Normalized On-Resistance vs Drain Current and Gate Voltage

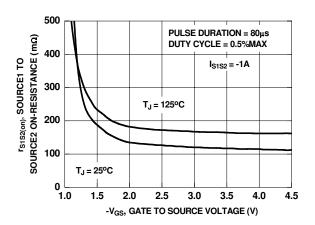


Figure 6. On-Resistance vs Gate to Source Voltage

Typical Characteristics T_J = 25 °C unless otherwise noted

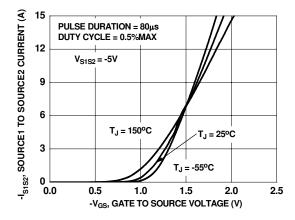


Figure 7. Transfer Characteristics

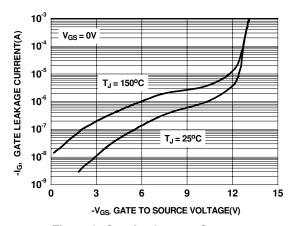


Figure 8. Gate Leakage vs Gate to Source Voltage

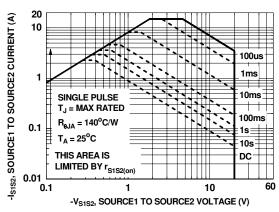


Figure 9. Forward Bias Safe Operating Area

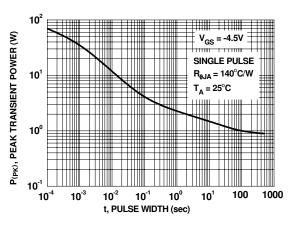


Figure 10. Single Pulse Maximum Power Dissipation

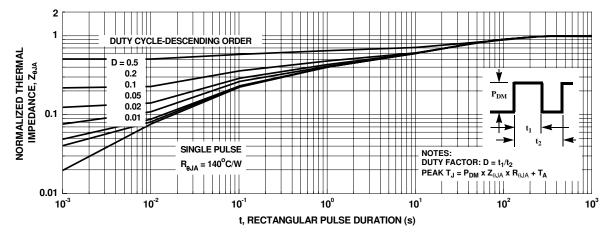
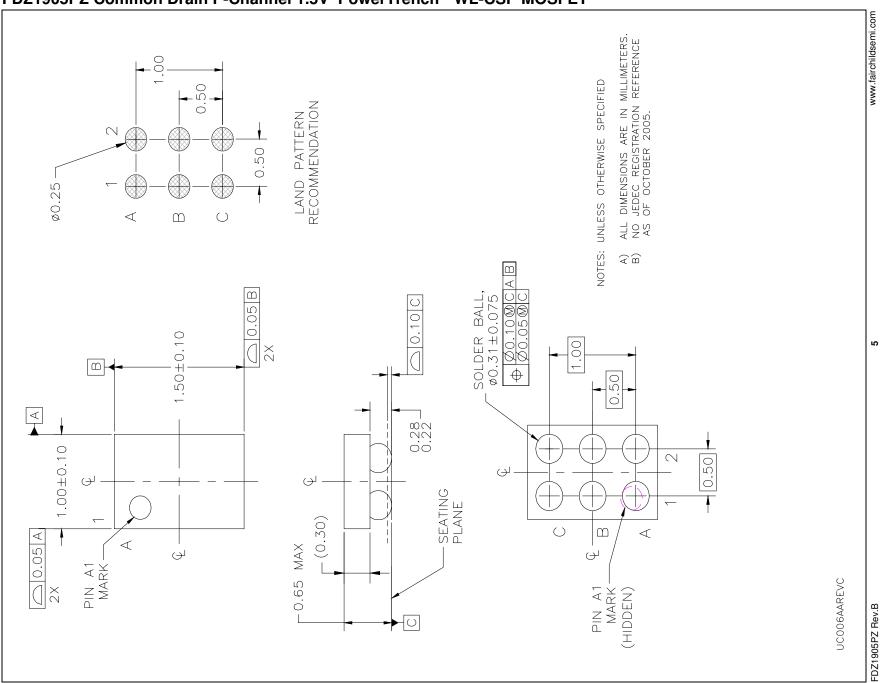


Figure 11. Transient Thermal Response Curve



Rev. 133





TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidianries, and is not intended to be an exhaustive list of all such trademarks.

^{*} EZSWITCH™ and FlashWriter® are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which,

 (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support, device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition			
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild Semiconductor. The datasheet is printed for reference information only.			

FDZ1905PZ Rev.B 6 www.fairchildsemi.com